

July 2012

UniFET™

FDP16N50 / FDPF16N50 / FDPF16N50T

500V N-Channel MOSFET

Features

- 16A, 500V, $R_{DS(on)} = 0.38\Omega @V_{GS} = 10 V$
- Low gate charge (typical 32 nC)
- Low C_{rss} (typical 20 pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability



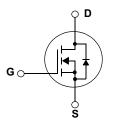
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.







Absolute Maximum Ratings

Symbol		Parameter		FDP16N50	FDPF16N50 / FDPF16N50T	Unit
V _{DSS}	Drain-Source Voltage		5	V		
I _D	Drain Current	- Continuous (T _C = 25°C) - Continuous (T _C = 100°C)		16 9.6	16 * 9.6 *	A A
I _{DM}	Drain Current	- Pulsed	(Note 1)	64	64 *	Α
V _{GSS}	Gate-Source voltage		±30		V	
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	780		mJ
I _{AR}	Avalanche Current		(Note 1)	16		Α
E _{AR}	Repetitive Avalanche Energy		(Note 1)	20		mJ
dv/dt	Peak Diode Recovery dv/dt (No		(Note 3)	4.5		V/ns
P _D	Power Dissipation	(T _C = 25°C) - Derate above 25°C		200 1.59	38.5 0.3	W/°C
T _{J,} T _{STG}	Operating and Storage Temperature Range		-55 to +150		°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300		°C	

^{*} Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP16N50	FDPF16N50 / FDPF16N50T	· IInit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.63	3.3	°C/W	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink Typ.	0.5		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDPF16N50	FDPF16N50	TO-220F	-	-	50
FDPF16N50T	FDPF16N50T	TO-220F	-	-	50

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
Off Charac	teristics			·		
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	500			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.5		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500V, V _{GS} = 0V V _{DS} = 400V, T _C = 125°C			1 10	μ Α μ Α
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V			-100	nA
On Charac	teristics				•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 8A		0.31	0.38	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 40V, I_D = 8A$ (Note 4)		23		S
Dynamic C	: Characteristics				•	
C _{iss}	Input Capacitance	$V_{DS} = 25V, V_{GS} = 0V,$		1495	1945	pF
C _{oss}	Output Capacitance	f = 1.0MHz		235	310	pF
C _{rss}	Reverse Transfer Capacitance			20	30	pF
Switching	Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250V, I _D = 16A		40	90	ns
t _r	Turn-On Rise Time	$R_{G} = 25\Omega$		150	310	ns
t _{d(off)}	Turn-Off Delay Time			65	140	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		80	170	ns
Qg	Total Gate Charge	V _{DS} = 400V, I _D = 16A		32	45	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10V		8.5		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		14		nC
Drain-Sour	ce Diode Characteristics and Maximun	n Ratings		·		
I _S	Maximum Continuous Drain-Source Diode Forward Current				9.2	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				37	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 16A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _S = 16A		490		ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note 4)		5.0		μС

NOTES

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 5.5mH, I $_{AS}$ = 16A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25°C
- 3. I $_{SD} \leq$ 16A, di/dt \leq 200A/µs, $V_{DD} \leq$ BV $_{DSS},$ Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse width $\leq 300 \mu s,$ Duty Cycle $\leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

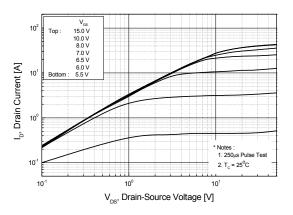


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

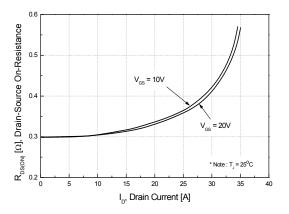


Figure 5. Capacitance Characteristics

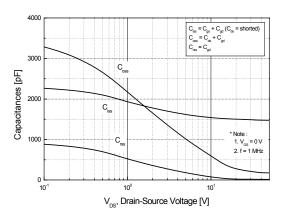


Figure 2. Transfer Characteristics

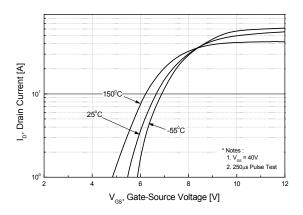


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

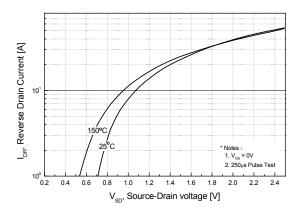
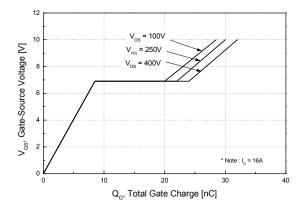


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

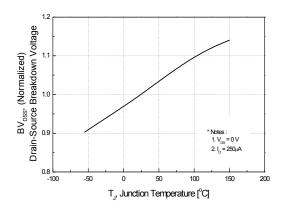


Figure 8. On-Resistance Variation vs. Temperature

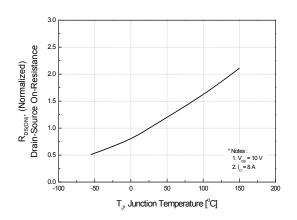


Figure 9-1. Maximum Safe Operating Area - FDP16N50

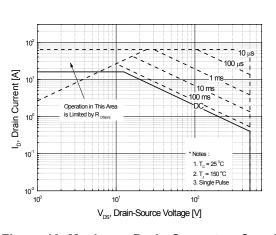


Figure 9-2. Maximum Safe Operating Area - FDPF16N50 / FDPF16N50T

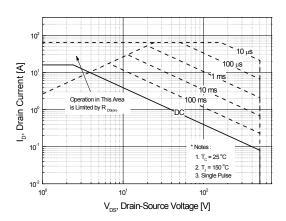
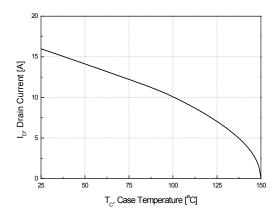


Figure 10. Maximum Drain Currentvs. Case Temperature



Typical Performance Characteristics (Continued)

Figure 11-1. Transient Thermal Response Curve - FDP16N50

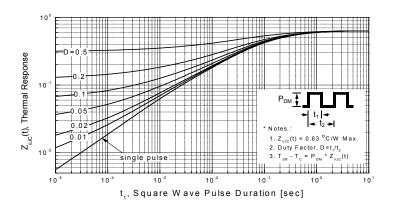
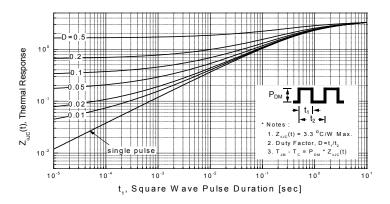
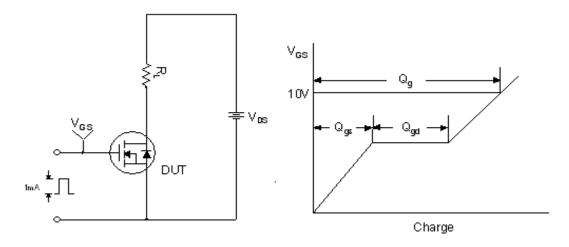


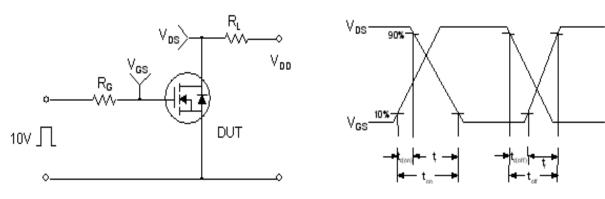
Figure 11-2. Transient Thermal Response Curve - FDPF16N50 / FDPF16N50T



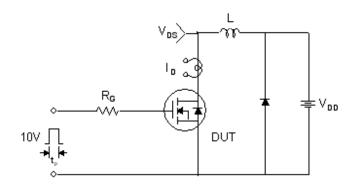
Gate Charge Test Circuit & Waveform

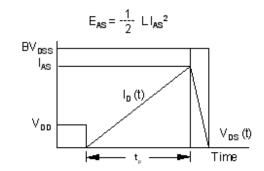


Resistive Switching Test Circuit & Waveforms

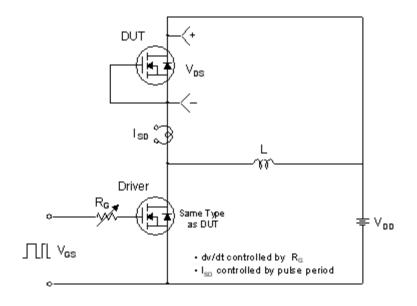


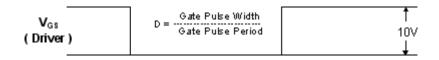
Unclamped Inductive Switching Test Circuit & Waveforms

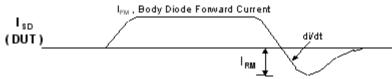




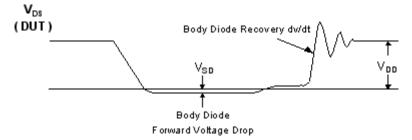
Peak Diode Recovery dv/dt Test Circuit & Waveforms





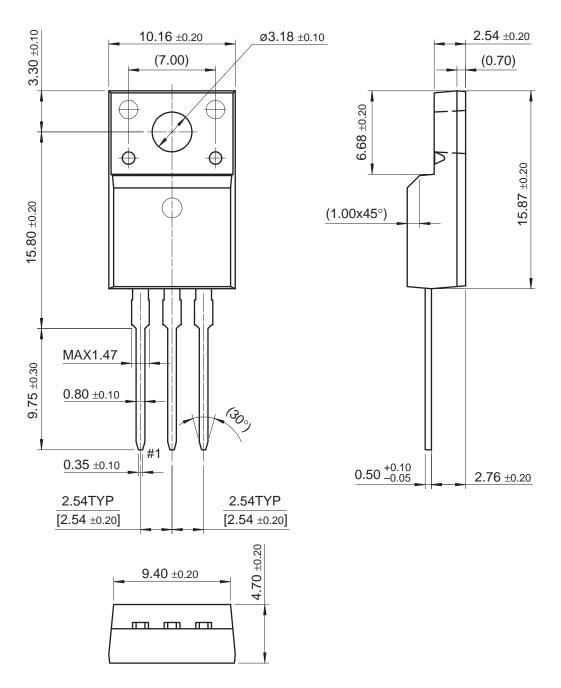


Body Diode Reverse Current



Mechanical Dimensions

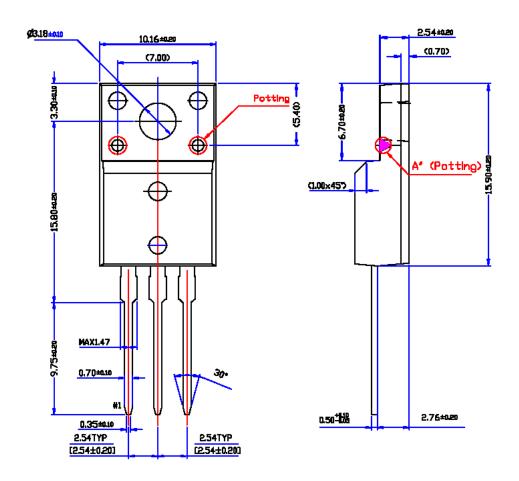
TO-220F



Dimensions in Millimeters

Package Dimensions

TO-220F Potted





* Front/Back Side Isolation Voltage : AC 2500V

Dimensions in Millimeters





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